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IN THE U.S. PATENT AND TRADEMARK OFFICE

March 22, 2006

Applicants: Hideki MISAWA et al
For: MAGNETIC MIGRATION AND REVERSAL DISPLAY PANEL AND
MAGNETIC MIGRATION AND REVERSAL DISPLAY METHOD
PCT International Application No.: PCT/JP2004/004625
PCT International Filing Date: March 31, 2004
U.S. Application No.
(if known, see 37 CFR 1.5): Unknown
Atty. Docket No.: 4700.P0325US

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Commissioner for Patents
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INFORMATION DISCLOSURE STATEMENT

Sir:

In compliance with the provisions of Rules 1.97(b)(1) and 1.98, enclosed herewith is a copy of the International Search Report, Form PTO-1449 and the references cited thereon. These references constitute the art known to the Applicants and are believed to be distinguishable from the claimed invention or are explained on the enclosed search report. Accordingly, further comment at this point in time should not be necessary.

Respectfully submitted,


Terryence F. Chapman

TFC/smd

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Encl: Copy of International Search Report
Form PTO-1449 and one copy of each listed reference

INFORMATION
DISCLOSURE
CITATION

Applicant: Hideki MISAWA et al

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U.S. PATENT DOCUMENTS

| Examiner Initials* | Cite No. | Document Number - Kind Code | Publication Date MM-DD-YYYY | Name of Patentee or Applicant |
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| | AB | | | |
| | AC | | | |
| | AD | | | |

FOREIGN PATENT DOCUMENTS

| Examiner Initials* | Cite No. | Country Code - Document Number - Kind Code | Publication Date MM-DD-YYYY | Name of Patentee or Applicant | Trans. |
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| | AG | JP 51-146924 | 06-11-1975 | OGATA | Abstract |
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| | AI | JP 60-107689 | 06-13-1985 | HOSAKA et al | Abstract |
| | AJ | WO 01/48548 | 07-05-2001 | IKEDA et al | Abstract |
| | AK | JP 2002-82363 | 03-22-2002 | OZAKI et al | Abstract |

NON PATENT LITERATURE DOCUMENTS

| Examiner Initials* | Cite No. | (Include Author, Title, Date, Pages, Etc.) |
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